

# Silicon Technology Leadership for the Mobility Era

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SPCS008



## **Agenda**

- Transistor Scaling Trends
- 32 nm SoC Technology
- 22 nm CPU Technology
- 22 nm SoC Technology

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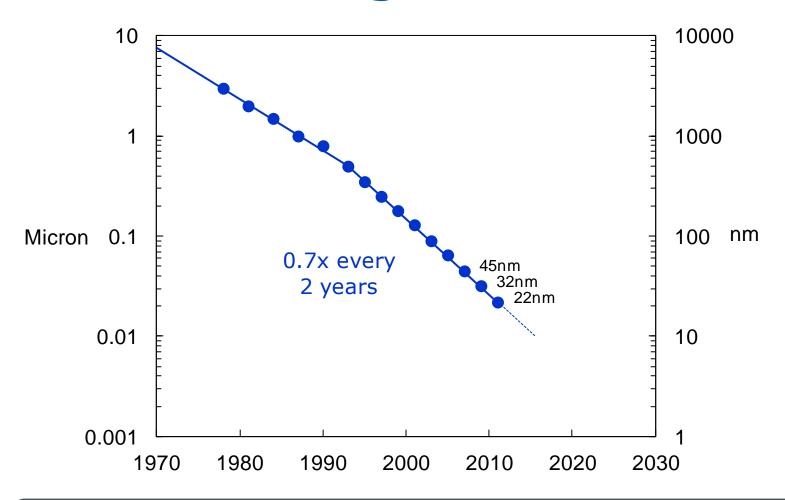


## **Agenda**

- Transistor Scaling Trends
- 32 nm SoC Technology
- 22 nm CPU Technology
- 22 nm SoC Technology



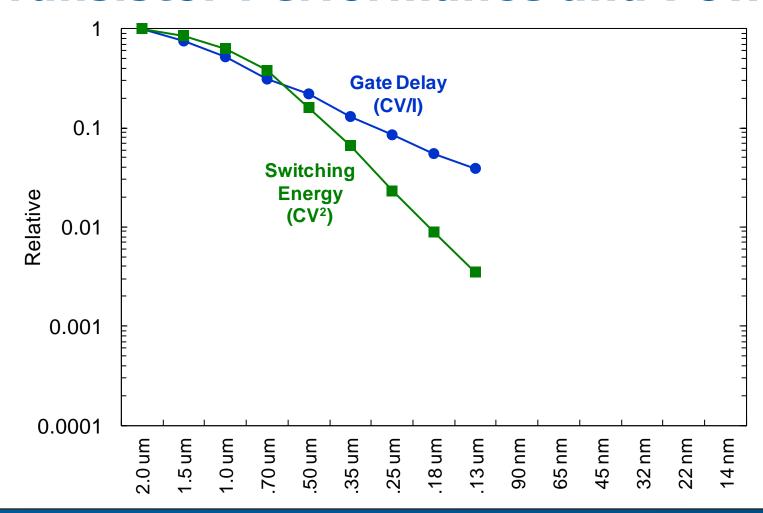
## **Transistor Scaling**



Transistor dimensions scale to improve performance, reduce power and reduce cost per transistor



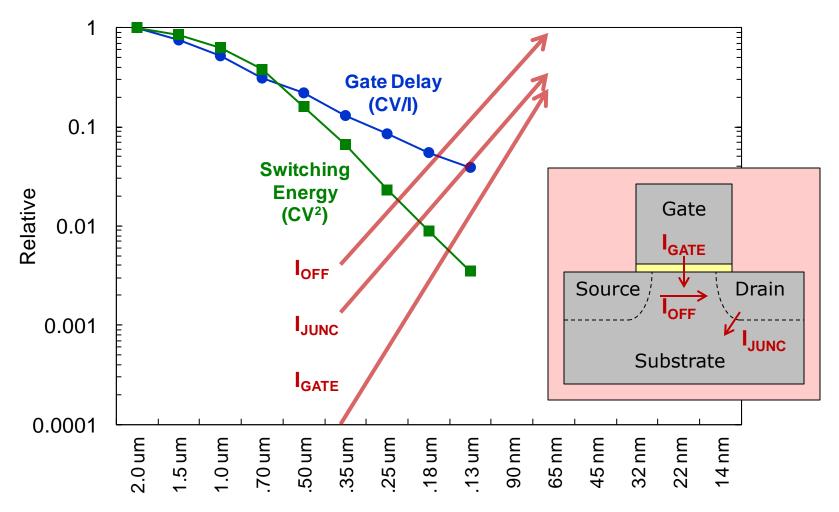
#### **Transistor Performance and Power**



"Classical" transistor scaling provided improvements in performance (gate delay) and active power (switching energy)



#### **Transistor Performance and Power**

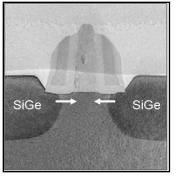


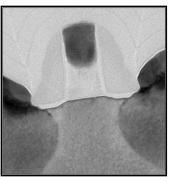
... but at the expense of increased leakage current

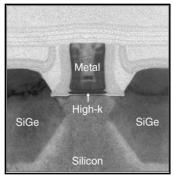


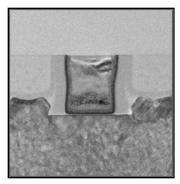
## **Non-Classical Scaling**

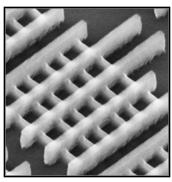
90 nm 2003 65 nm 2005 45 nm 2007 32 nm 2009 22 nm 2011











Strained Silicon

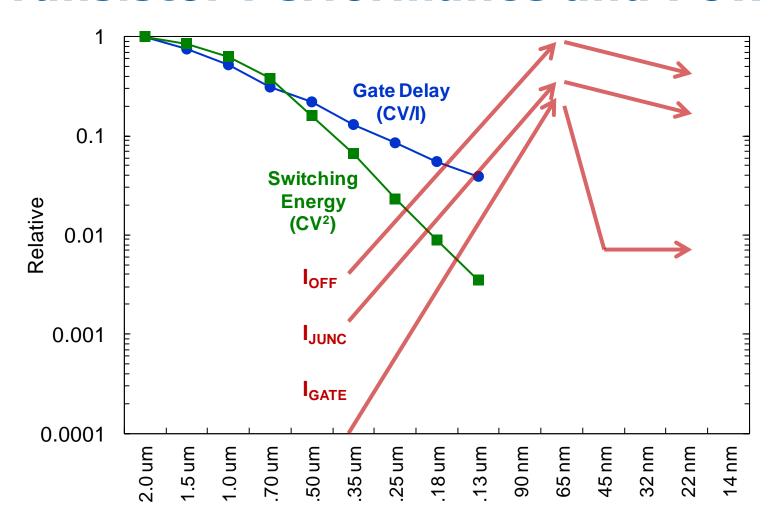
High-k Metal Gate

Tri-Gate

Scaling now requires continual innovations in transistor structure and materials



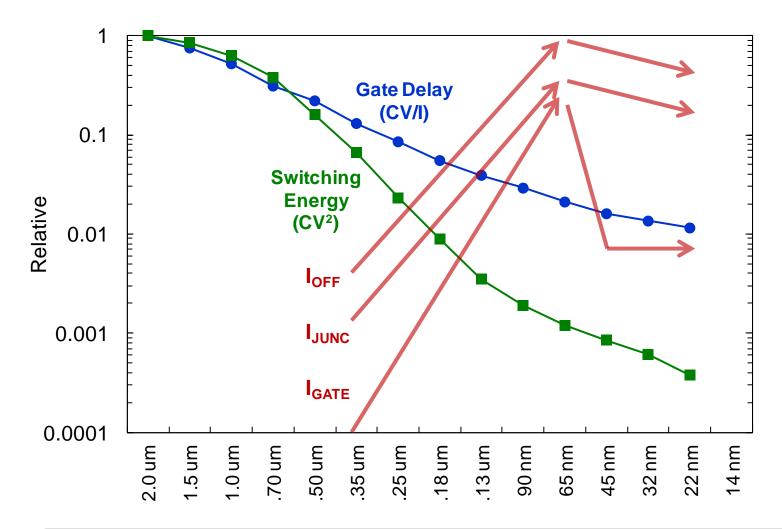
#### **Transistor Performance and Power**



Transistor scaling now focuses on reducing leakage



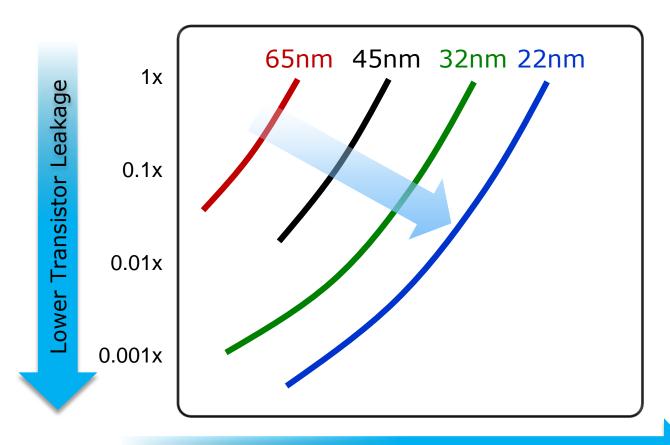
#### **Transistor Performance and Power**



... and continues to improve performance and power



## **Transistor Performance vs. Leakage**



**Higher Transistor Performance (Switching Speed)** 

Transistors now improve on both performance and leakage vectors



## **Transistor Performance vs. Leakage**

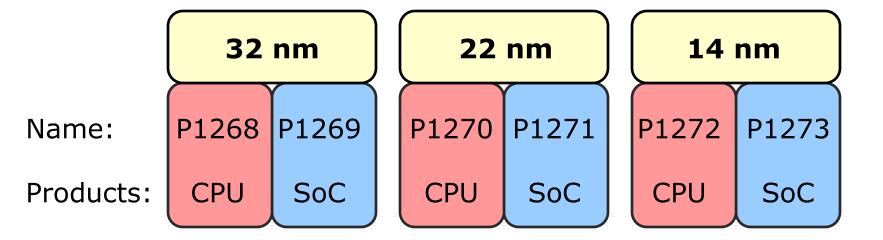


**Higher Transistor Performance (Switching Speed)** 

Wider range of transistors to support a wider range of products



## Intel® Technology Roadmap



Intel develops both CPU and SoC versions of each generation



## Intel® Technology Roadmap

32 nm 22 nm 14 nm P1268 P1269 P1270 P1271 P1272 P1273 Name: CPU **Products:** CPU SoC SoC **CPU** SoC

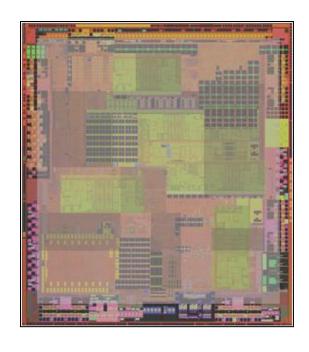
Intel develops both CPU and SoC versions of each generation



## **Low Power Smartphone Products**



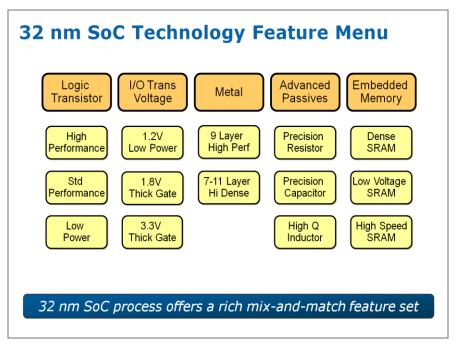
Medfield Phone

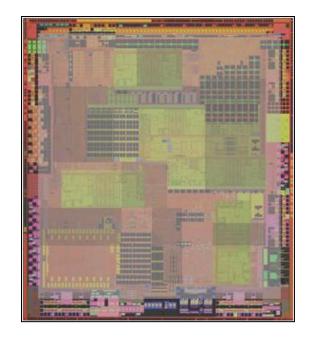


32 nm Intel® Atom™ processor (Medfield) SoC 432 million transistors, 64 mm²



## **Low Power Smartphone Products**





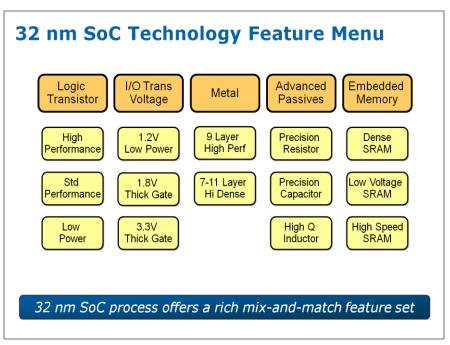
Intel Developer Forum, Sep. 2009

32 nm SoC Technology

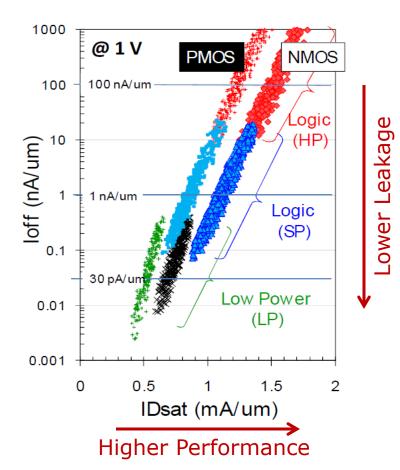
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## **Low Power Smartphone Products**



Intel Developer Forum, Sep. 2009

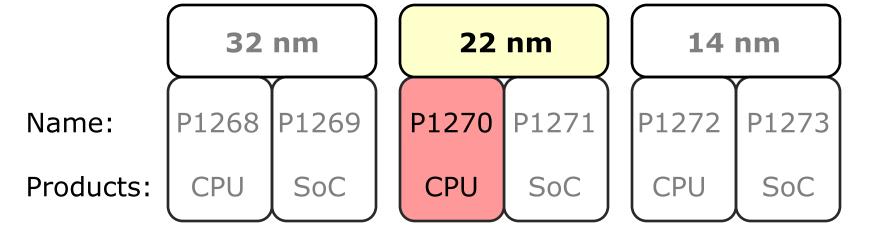


32 nm SoC Technology

32 nm SoC transistors range from high performance to low power



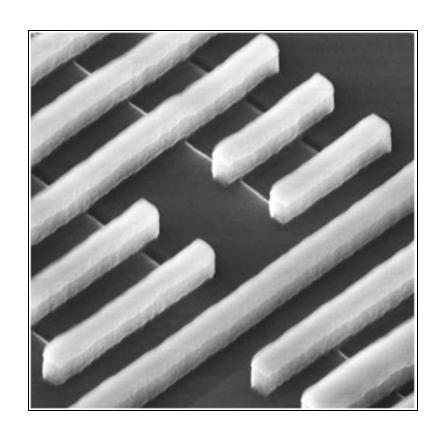
## Intel® Technology Roadmap

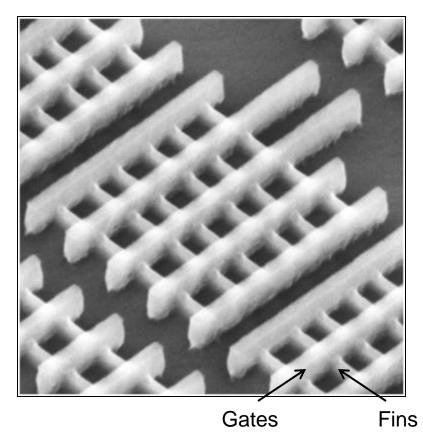




# **32 nm Planar Transistors**

# 22 nm Tri-Gate Transistors

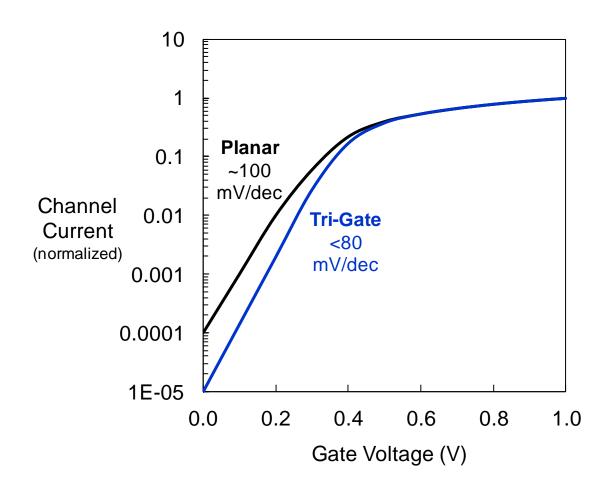




22 nm generation introduces revolutionary 3-D Tri-Gate transistors

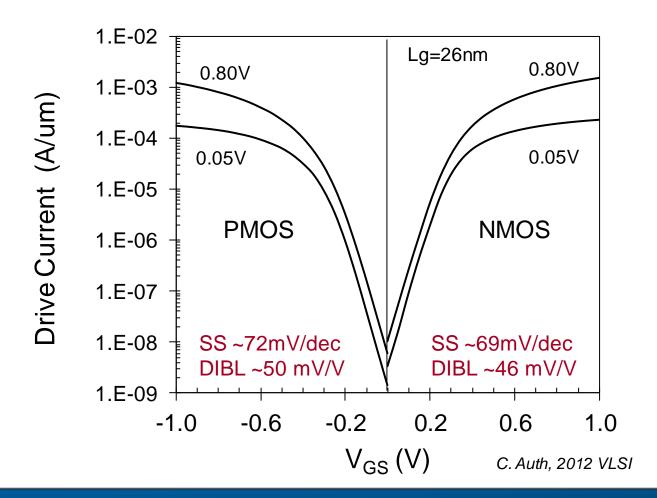


## **Fully Depleted Device**



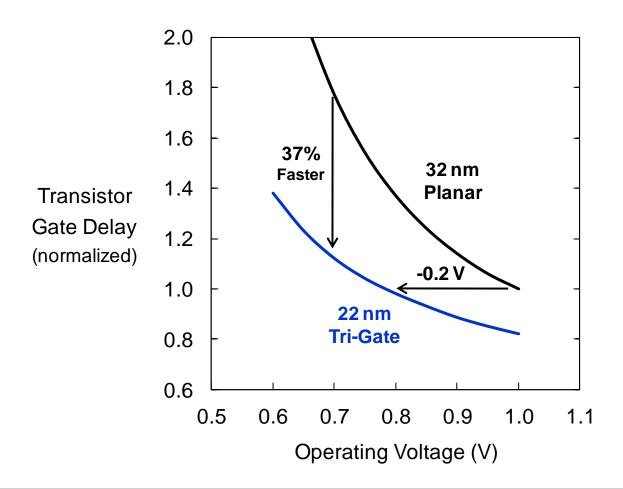
Tri-Gate transistors are fully depleted devices offering a steeper sub-threshold slope

#### 22 nm Tri-Gate I-V Curves



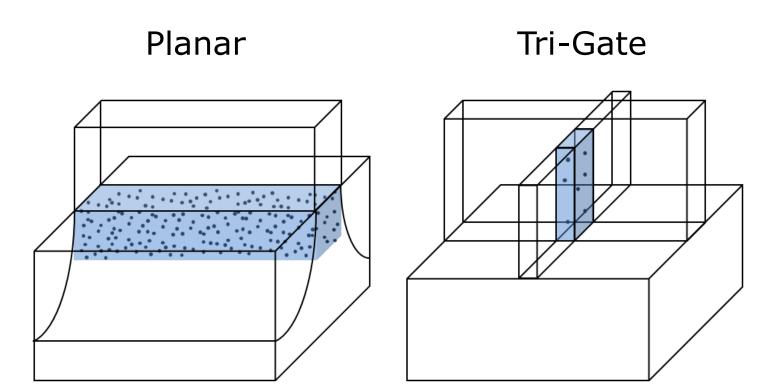
Tri-Gate provides steepest sub-threshold slope and best short channel (DIBL) values of any technology in manufacturing

## **Performance/Power Benefits**



Tri-Gate provides 37% speed up at low voltage or 50% active power reduction at same performance

## **Reduced Channel Doping**

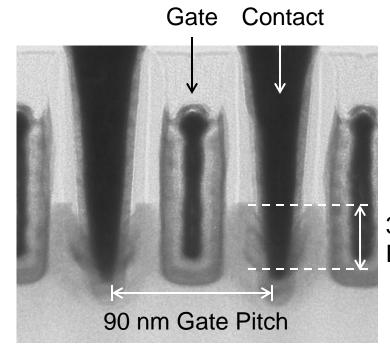


Fully depleted Tri-Gate structure has reduced channel doping, providing improved performance and reduced variability

#### 22 nm Tri-Gate Transistors

34 nm
Fin Height

----8nm
Fin
Width

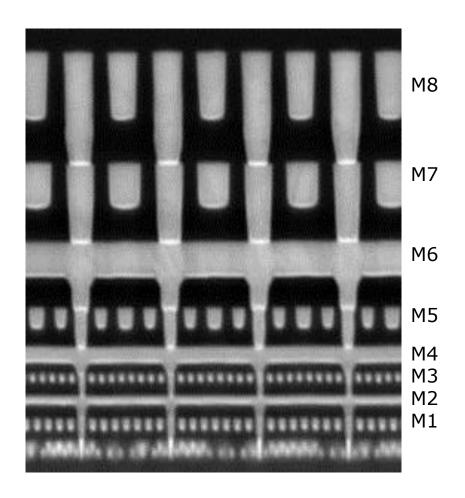


34 nm Fin Height



#### 22 nm Interconnects

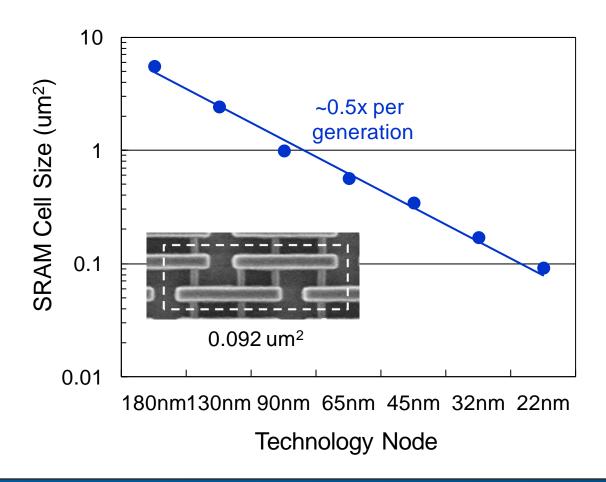
<u>Layer</u>	<u>Pitch</u>			
TM	14 um			
M8	360 nm			
M7	320 nm			
M6	240 nm			
M5	160 nm			
M4	112 nm			
М3	80 nm			
M2	80 nm			
M1	90 nm			



Minimum pitch scaled ~0.7x from 32 nm for ~2x transistor density improvement

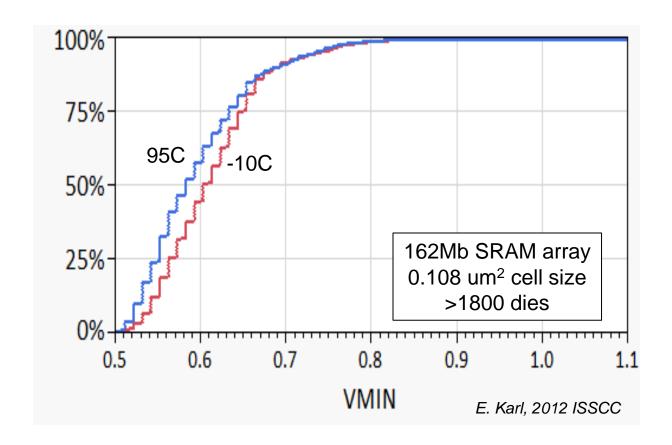


#### **SRAM Cells**



0.092 um<sup>2</sup> and 0.108 um<sup>2</sup> SRAM cells optimized for density and performance/power

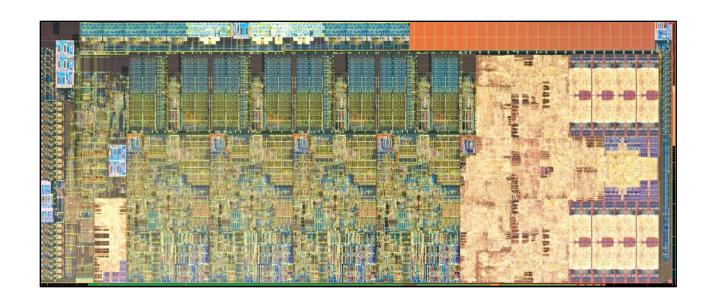
## **SRAM Array V<sub>MIN</sub>**



0.60V medium active  $V_{MIN}$  for low power applications



#### **3RD** Generation Intel® Core™ Processor



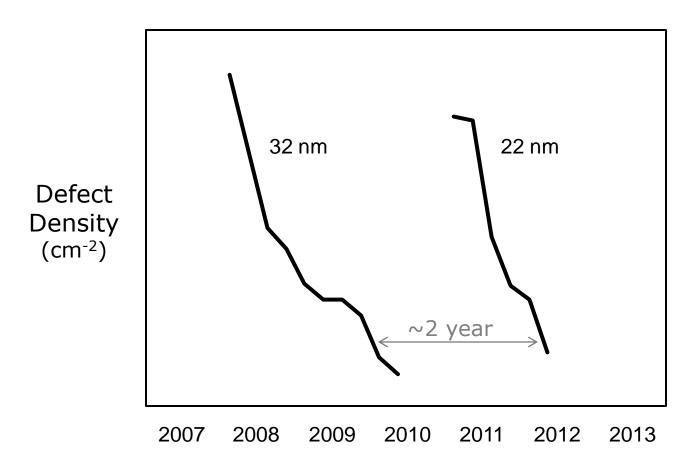
22 nm Tri-Gate Technology

4 Cores + Integrated Graphics

1.4 Billion Transistors, 160 mm<sup>2</sup>



## 22 nm Defect Density Trend



22 nm defect density now at low levels needed for volume manufacturing



## 22 nm Manufacturing Fabs



D1D Oregon 

✓



D1C Oregon



Fab 32 Arizona 🗸



Fab 28 Israel 🗸



Fab 12 Arizona

✓ In production 2Q '12



## Intel® Technology Roadmap

32 nm 22 nm 14 nm P1268 P1269 P1270 P1271 P1272 P1273 Name: **CPU** SoC CPU SoC CPU Products: SoC



## CPU vs. SoC Technology Comparison

#### **CPU (P1270)**

#### **SoC (P1271)**

#### **Similarities**

Tri-Gate Structure

Tight Transistor Pitch

Dense SRAM Cell

Lower Level Interconnects

Fab Process Equipment

#### Differences

Logic Transistors

I/O Transistors

Upper Level Interconnects

**Precision Passives** 

Same

Same

Same

Same

Same

High Speed

Std Voltage

High Speed

None

Same

Same

Same

Same

Same

Low Leakage

Std and High Volt

Dense

R, C and L



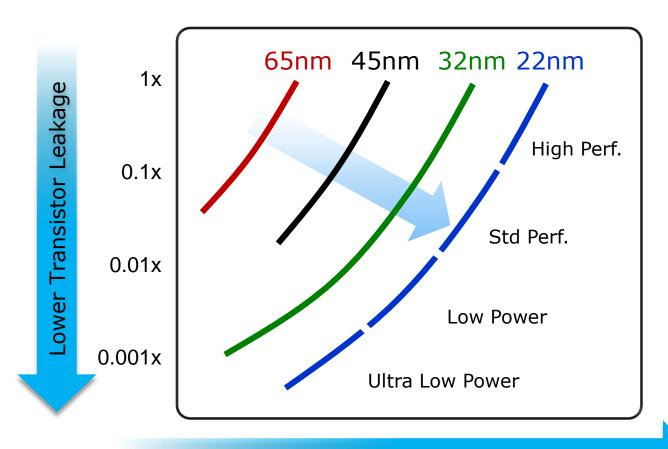
## 22 nm SoC Technology Features

I/O Trans **Embedded** Logic **Passives** Metal Voltage **Transistor** Memory High Dense High 1.2V 8-11 Layer Precision Low Power Stacks **SRAM** Performance Resistor Std 1.8V MIM Low Voltage Performance Capacitor **SRAM** Thick Gate 3.3V High Q High Speed Low SRAM Thick Gate Inductor Power Ultra **HD OTP** e-Fuse Low Power

22 nm SoC technology offers a rich menu of feature options



## **Transistor Performance vs. Leakage**

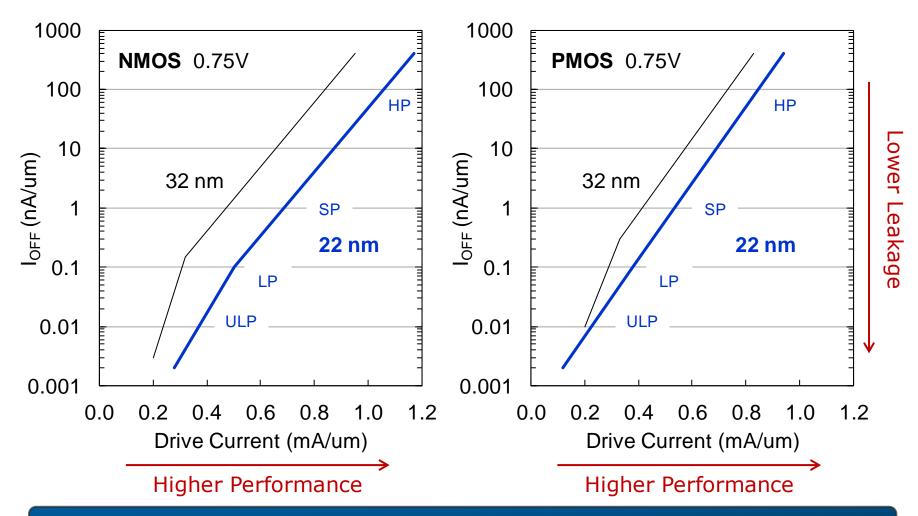


Higher Transistor Performance (Switching Speed)

22 nm SoC technology offers a wide range of transistors



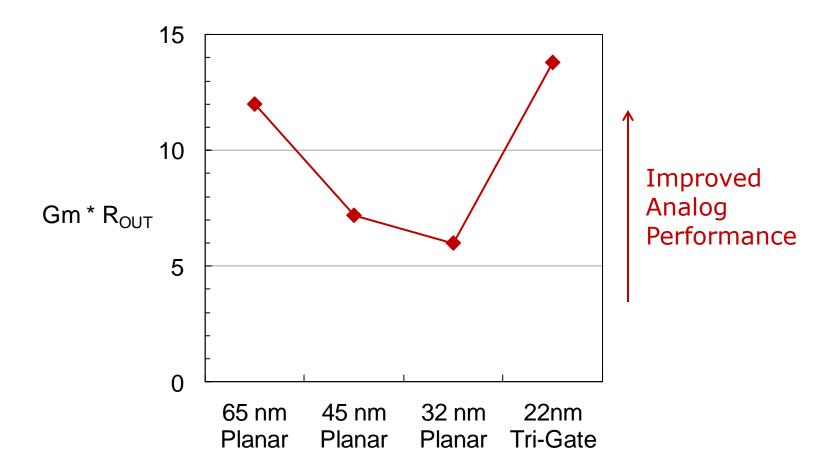
## **Transistor Performance vs. Leakage**



22 nm SoC technology offers a wide range of transistors



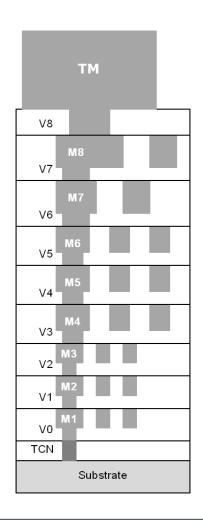
## **Analog Device Characteristics**



22 nm Tri-Gate transistors provide improved Gm \* R<sub>OUT</sub> for improved analog circuit performance



## 22 nm SoC Interconnect Options

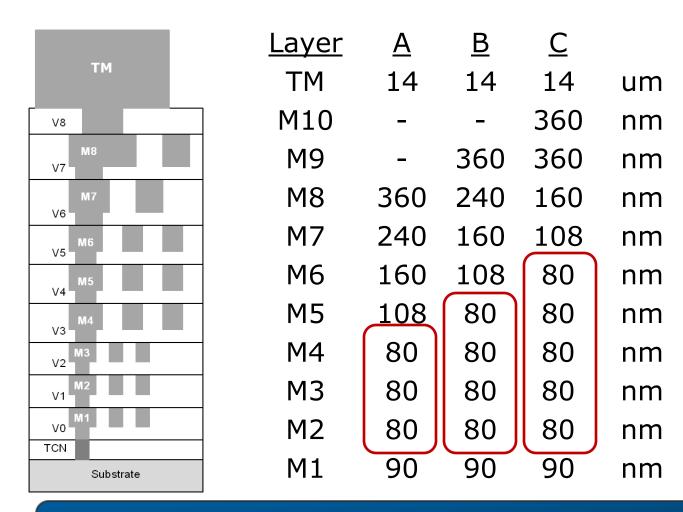


<u>Layer</u>	<u>A</u>	<u>B</u>	<u>C</u>	
TM	14	14	14	um
M10	-	-	360	nm
M9	-	360	360	nm
M8	360	240	160	nm
M7	240	160	108	nm
M6	160	108	80	nm
M5	108	80	80	nm
M4	80	80	80	nm
М3	80	80	80	nm
M2	80	80	80	nm
M1	90	90	90	nm

Range of SoC interconnect options for low cost or high density



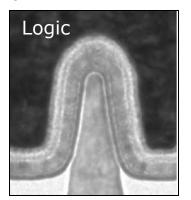
## 22 nm SoC Interconnect Options

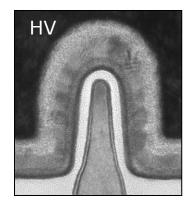


80 nm pitch is done with single patterning, thus an optimal pitch to use for this generation

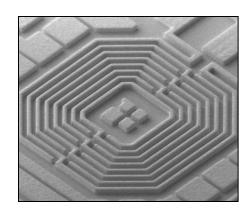
#### 22 nm SoC Device Features

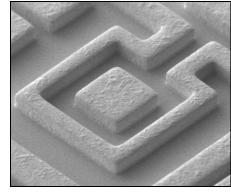
High Voltage I/O Transistors



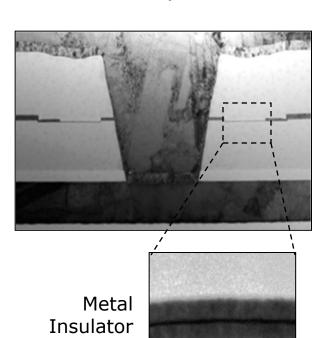


**Inductors** 





MIM Capacitor

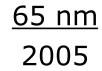


Metal

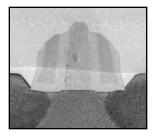


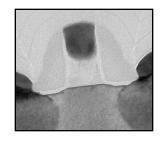
## 2 Year Technology Cycles

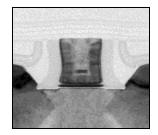
90 nm 2003

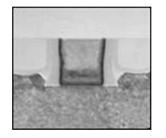


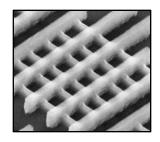
45 nm 2007 32 nm 2009 22 nm 2011

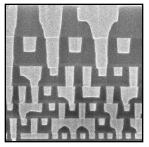


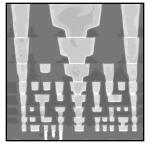




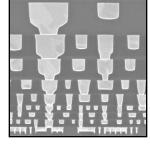


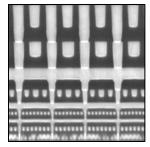


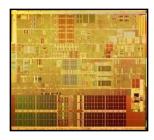


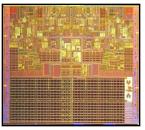


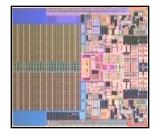


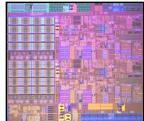


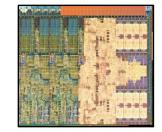






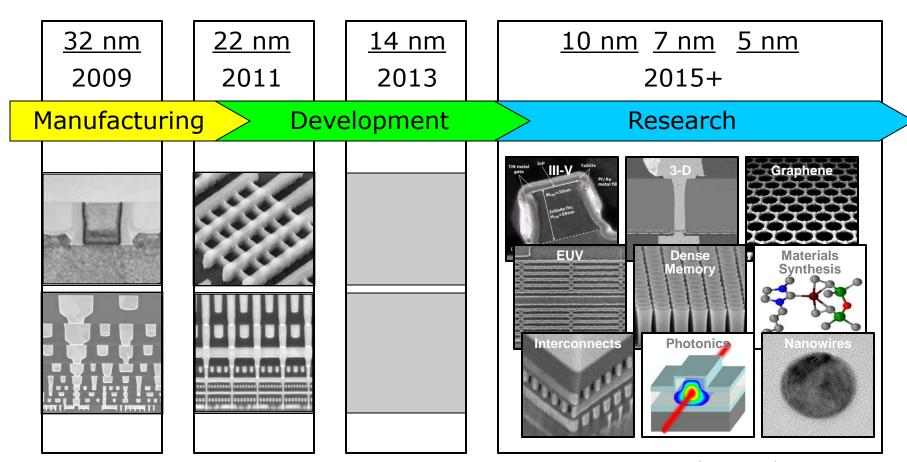








### **Innovation Enabled Technology Pipeline**



Future options subject to change



## Advantage of an Integrated Device Manufacturer

#### Research

#### Components Research

Equipment Vendors
Industry Consortia
Universities
Government Labs

Identify innovative technologies



## Advantage of an Integrated Device Manufacturer

#### Research

#### **Development**

Components Research Product Design

Logic Technology Development

Equipment Vendors
Industry Consortia
Universities
Government Labs

Design Tools Photo Masks Packaging

Identify innovative technologies

- Co-optimize process+product
- Design for manufacturing



## Advantage of an Integrated Device Manufacturer

Research

**Development** 

**Manufacturing** 

Components Research Product Design

Logic Technology Development Wafer Manufacturing Fabs

Equipment Vendors
Industry Consortia
Universities
Government Labs

Design Tools Photo Masks Packaging

Oregon Arizona New Mexico Israel Ireland China

Identify innovative technologies

- Co-optimize process+product
- Design for manufacturing

- Early product ramp
- Rapid yield learning



## **Summary**

- Transistor scaling continues to provide improvements in performance, power and cost, but now with greater focus on power reduction
- Scaling no longer follows a "classical" path and requires continued innovations in materials and structures
- A highly integrated approach is needed to successfully bring innovative technologies from the research phase to high volume manufacturing
- Low power System-on-Chip technologies are increasingly important to support the wide range of features needed on mobile computing devices



# Additional Sources of Information on This Topic:

More web based info:

www.intel.com/technology/architecture-silicon



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